

# IGBT Chip in NPT-technology

#### **FEATURES:**

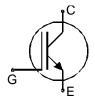
- 1200V NPT technology 175µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling
- integrated gate resistor

## This chip is used for:

• IGBT Modules

# Applications:

• drives, SMPS, resonant applications



Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC81T120R2CS	1200V	50A	9.08 X 8.98 mm <sup>2</sup>	sawn on foil	Q67050- A4050-A001

## **MECHANICAL PARAMETER:**

Raster size	9.08 X 8.98	mm <sup>2</sup>		
Emitter pad size	8 x (2.6 x 1.78)			
Gate pad size	1.46 x 0.8			
Area total / active	81.5 / 63.5			
Thickness	175	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	167 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



## **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	1200	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	150	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

# STATIC CHARACTERISTICS (tested on chip), $T_{\rm j}$ =25 °C, unless otherwise specified:

Parameter	Symbol Conditions		Value			Unit	
i arameter	Oymbor	Conditions	min.	typ.	max.		
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V , I <sub>C</sub> =3mA	1200				
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =50A	2.7	3.2	3.7	V	
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I <sub>C</sub> =2mA , V <sub>GE</sub> =V <sub>CE</sub>	4.5	5.5	6.5		
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			300	μA	
Gate-emitter leakage current	$I_{GES}$	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			300	nA	
Integrated gate resistor	R <sub>Gint</sub>			5	7	Ω	

## **ELECTRICAL CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiametei	Conditions		min.	typ.	max.	John
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	3.3		nF
Output capacitance	Coss	$V_{GE}=0V$ ,	-	0.5		
Reverse transfer capacitance	Crss	f=1MHz	-	0.22		

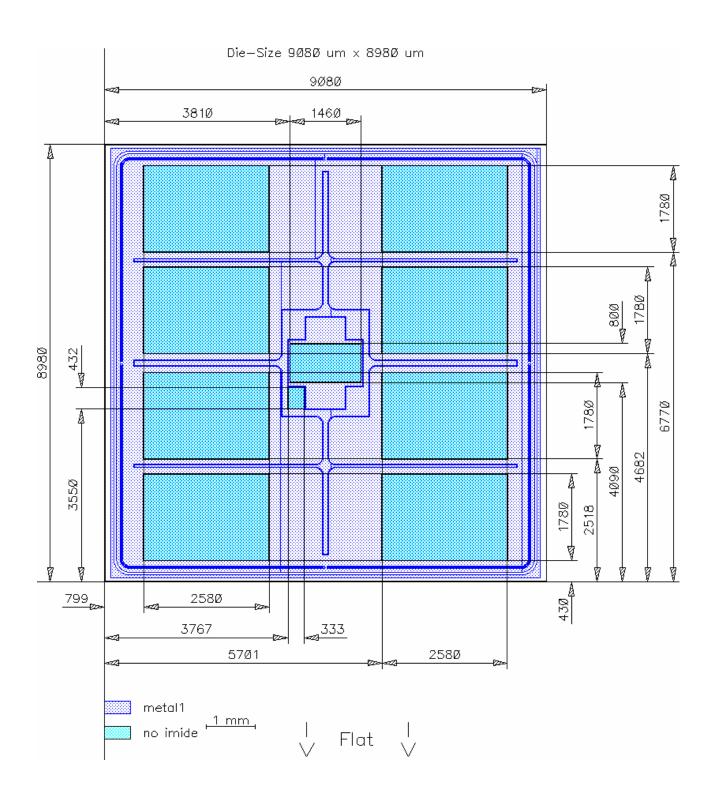
# SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions 1)	Value			Unit
- arameter	Syllibol	Conditions	min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =125°C	1	tbd		ns
Rise time	$t_{\rm r}$	V <sub>CC</sub> =600V,	1	tbd		
Turn-off delay time	$t_{d(off)}$	I <sub>C</sub> =50A, V <sub>GE</sub> =-15/15V,	ı	tbd		
Fall time	$t_{f}$	$R_{G} = x \times \Omega$	-	tbd		

<sup>&</sup>lt;sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



### **CHIP DRAWING:**





## **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet	tbd				
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

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